

IRF7757GPbF

HEXFET® Power MOSFET

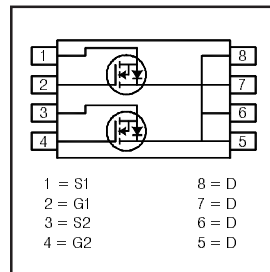
- Ultra Low On-Resistance
- Dual N-Channel MOSFET
- Very Small SOIC Package
- Low Profile (< 1.2mm)
- Available in Tape & Reel
- Common Drain Configuration
- Lead-Free
- Halogen-Free

| V _{DS} | R _{DS(on)} max (mΩ) | I _D |
|-----------------|------------------------------|----------------|
| 20V | 35 @ V _{GS} = 4.5V | 4.8A |
| | 40 @ V _{GS} = 2.5V | 3.8A |

Description

HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the ruggedized device design, that International Rectifier is well known for, provides the designer with an extremely efficient and reliable device for battery and load management.

The TSSOP-8 package has 45% less footprint area than the standard SO-8. This makes the TSSOP-8 an ideal device for applications where printed circuit board space is at a premium. The low profile (<1.2mm) allows it to fit easily into extremely thin environments such as portable electronics and PCMCIA cards.



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|--|--|--------------|-------|
| V _{DS} | Drain- Source Voltage | 20 | V |
| I _D @ T _A = 25°C | Continuous Drain Current, V _{GS} @ 4.5V | 4.8 | A |
| I _D @ T _A = 70°C | Continuous Drain Current, V _{GS} @ 4.5V | 3.9 | |
| I _{DM} | Pulsed Drain Current ① | 19 | |
| P _D @ T _A = 25°C | Power Dissipation ③ | 1.2 | W |
| P _D @ T _A = 70°C | Power Dissipation ③ | 0.76 | |
| | Linear Derating Factor | 9.5 | mW/°C |
| V _{GS} | Gate-to-Source Voltage | ± 12 | V |
| T _J , T _{STG} | Junction and Storage Temperature Range | -55 to + 150 | °C |

Thermal Resistance

| | Parameter | Max. | Units |
|------------------|-------------------------------|------|-------|
| R _{θJA} | Maximum Junction-to-Ambient ③ | 105 | °C/W |

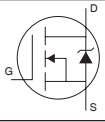
IRF7757GPbF

International
IR Rectifier

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|---------------------------------|--------------------------------------|------|-------|------|-------|---|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | 20 | — | — | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | — | 0.013 | — | V/°C | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$ |
| $R_{DS(on)}$ | Static Drain-to-Source On-Resistance | — | — | 35 | mΩ | $V_{GS} = 4.5V, I_D = 4.8A$ ② |
| | | — | — | 40 | | $V_{GS} = 2.5V, I_D = 3.8A$ ② |
| $V_{GS(th)}$ | Gate Threshold Voltage | 0.60 | — | 1.2 | V | $V_{DS} = V_{GS}, I_D = 250\mu A$ |
| g_{fs} | Forward Transconductance | 11 | — | — | S | $V_{DS} = 10V, I_D = 4.8A$ |
| I_{DSS} | Drain-to-Source Leakage Current | — | — | 1.0 | μA | $V_{DS} = 16V, V_{GS} = 0V$ |
| | | — | — | 25 | | $V_{DS} = 16V, V_{GS} = 0V, T_J = 70^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | $V_{GS} = 12V$ |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | $V_{GS} = -12V$ |
| Q_g | Total Gate Charge | — | 15 | 23 | nC | $I_D = 4.8A$ |
| Q_{gs} | Gate-to-Source Charge | — | 2.5 | — | | $V_{DS} = 16V$ |
| Q_{gd} | Gate-to-Drain ("Miller") Charge | — | 4.8 | — | | $V_{GS} = 4.5V$ |
| $t_{d(on)}$ | Turn-On Delay Time | — | 9.5 | — | ns | $V_{DD} = 10V$ ② |
| t_r | Rise Time | — | 9.2 | — | | $I_D = 1.0A$ |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 36 | — | | $R_G = 6.2\Omega$ |
| t_f | Fall Time | — | 14 | — | | $V_{GS} = 4.5V$ |
| C_{ISS} | Input Capacitance | — | 1340 | — | pF | $V_{GS} = 0V$ |
| C_{OSS} | Output Capacitance | — | 180 | — | | $V_{DS} = 15V$ |
| C_{RSS} | Reverse Transfer Capacitance | — | 132 | — | | $f = 1.0\text{MHz}$ |

Source-Drain Ratings and Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|----------|--|------|------|------|-------|--|
| I_S | Continuous Source Current (Body Diode) | — | — | 1.2 | A | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I_{SM} | Pulsed Source Current (Body Diode) ① | — | — | 19 | | |
| V_{SD} | Diode Forward Voltage | — | — | 1.2 | V | $T_J = 25^\circ\text{C}, I_S = 1.2A, V_{GS} = 0V$ ② |
| t_{rr} | Reverse Recovery Time | — | 20 | 30 | ns | $T_J = 25^\circ\text{C}, I_F = 1.2A$ |
| Q_{rr} | Reverse Recovery Charge | — | 10 | 15 | nC | $di/dt = 100A/\mu s$ ② |

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width $\leq 400\mu s$; duty cycle $\leq 2\%$.
- ③ Surface mounted on 1 in square Cu board

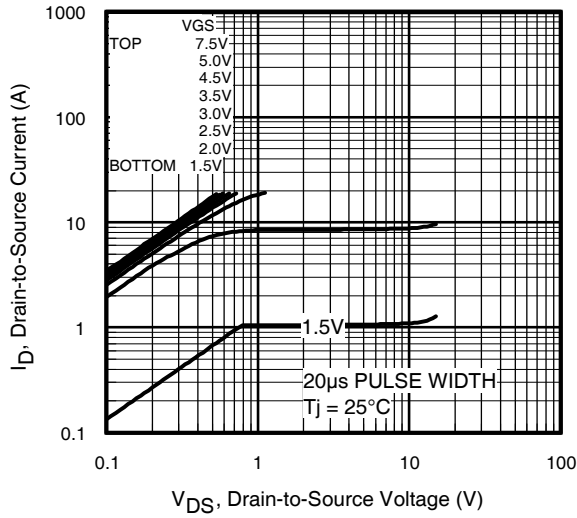


Fig 1. Typical Output Characteristics

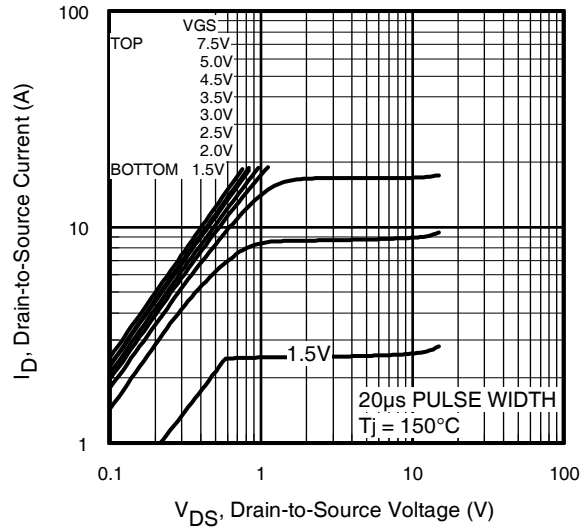


Fig 2. Typical Output Characteristics

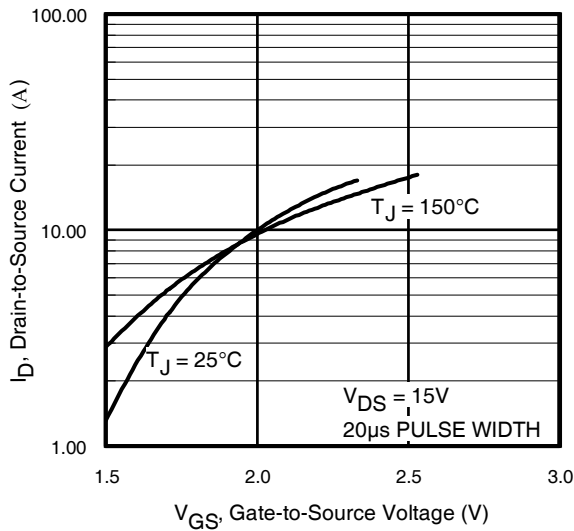


Fig 3. Typical Transfer Characteristics

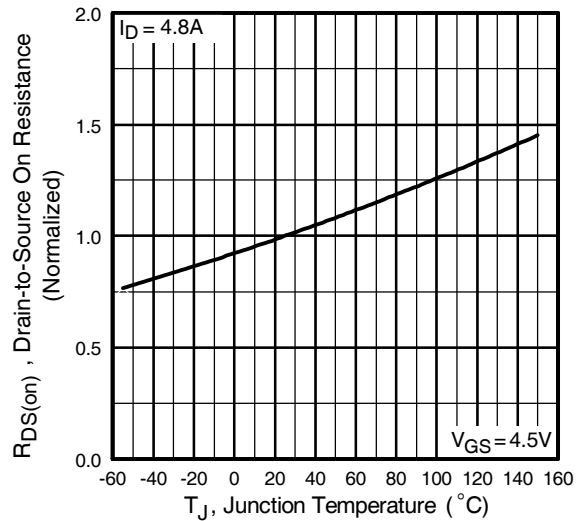


Fig 4. Normalized On-Resistance Vs. Temperature

IRF7757GPbF

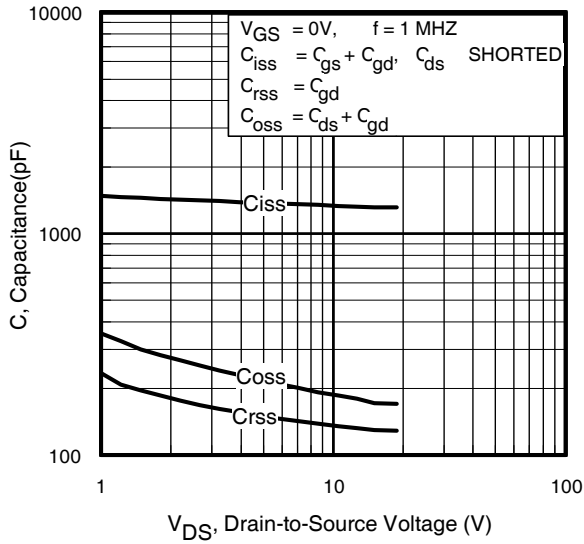


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

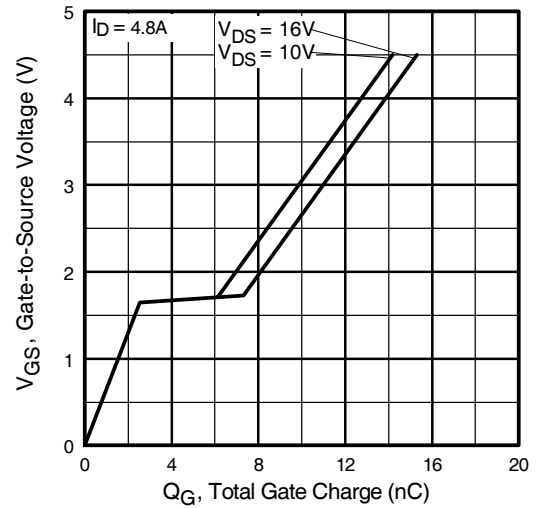


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

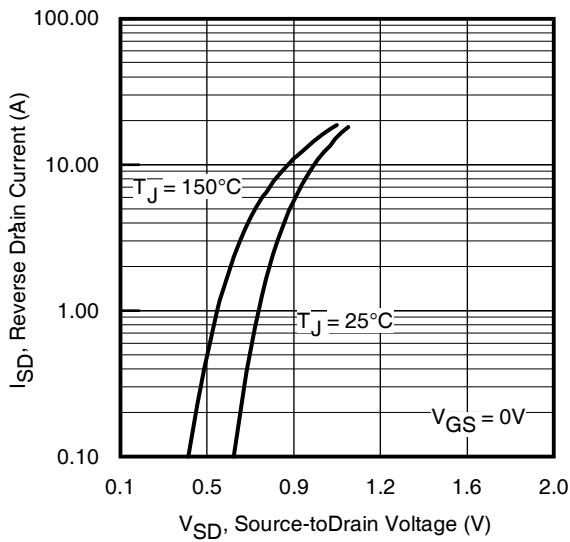


Fig 7. Typical Source-Drain Diode Forward Voltage

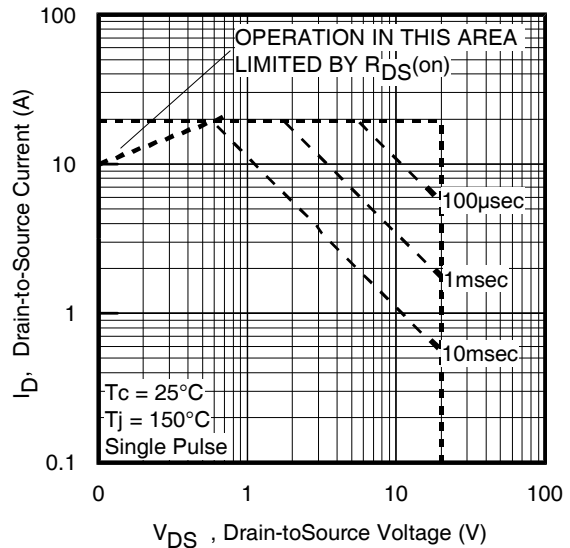


Fig 8. Maximum Safe Operating Area

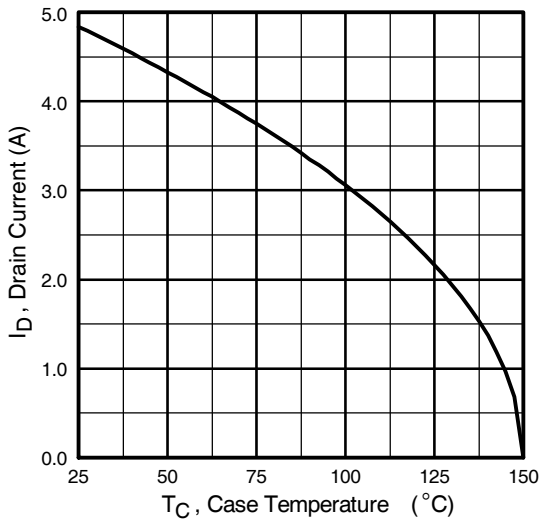


Fig 9. Maximum Drain Current Vs. Case Temperature

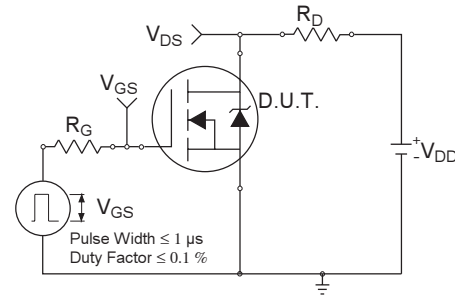


Fig 10a. Switching Time Test Circuit

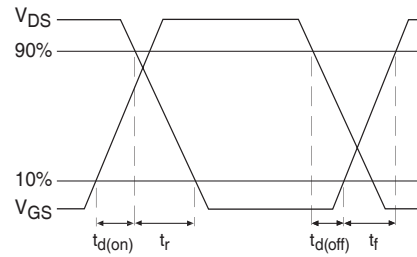


Fig 10b. Switching Time Waveforms

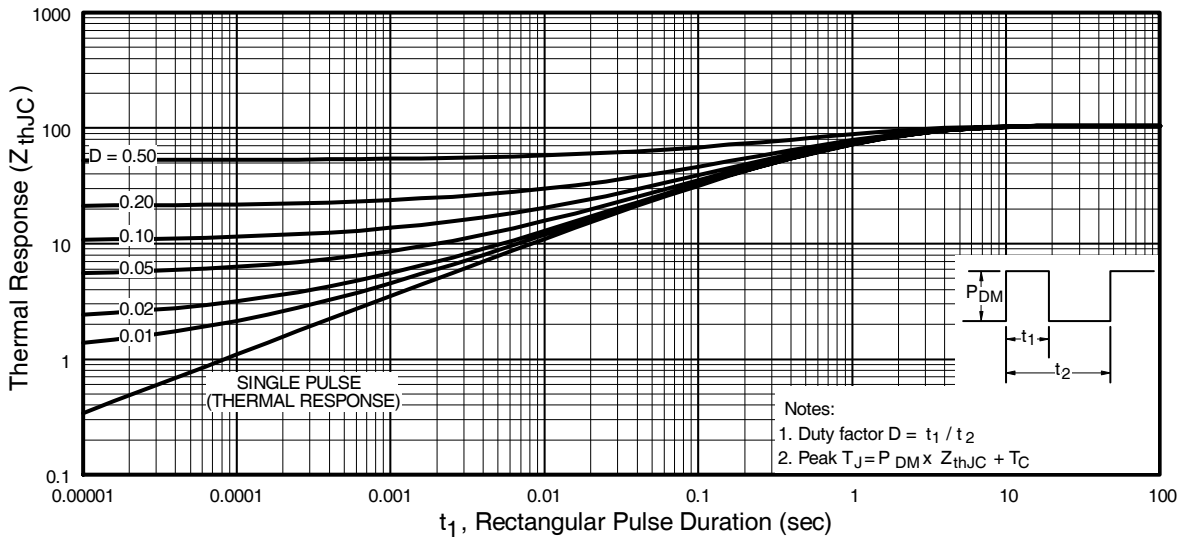


Fig 11. Typical Effective Transient Thermal Impedance, Junction-to-Ambient

IRF7757GPbF

International
IR Rectifier

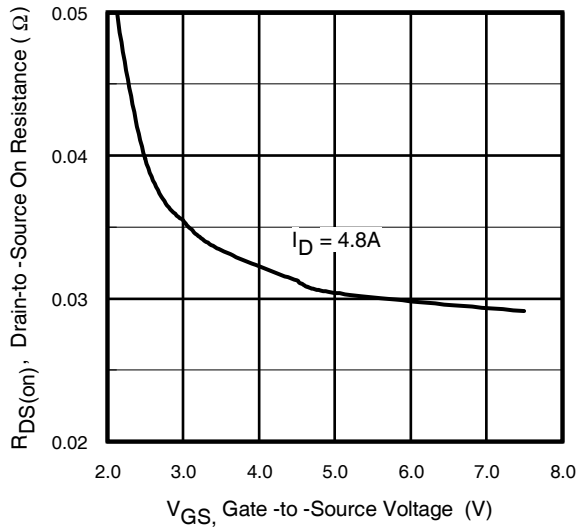


Fig 12. Typical On-Resistance Vs. Gate Voltage

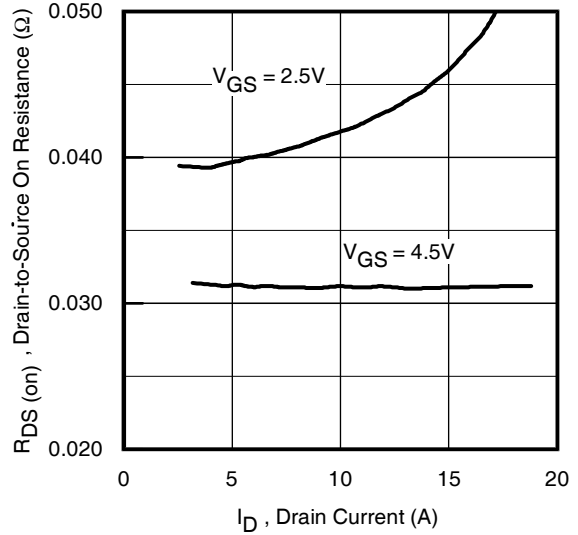


Fig 13. Typical On-Resistance Vs. Drain Current

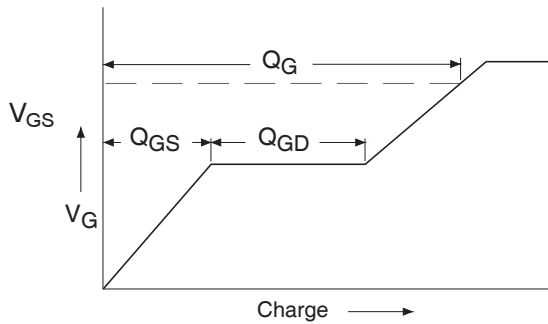


Fig 14a. Basic Gate Charge Waveform

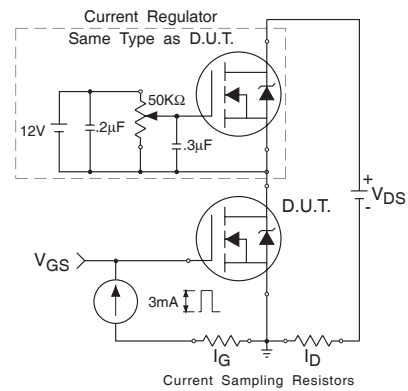


Fig 14b. Gate Charge Test Circuit

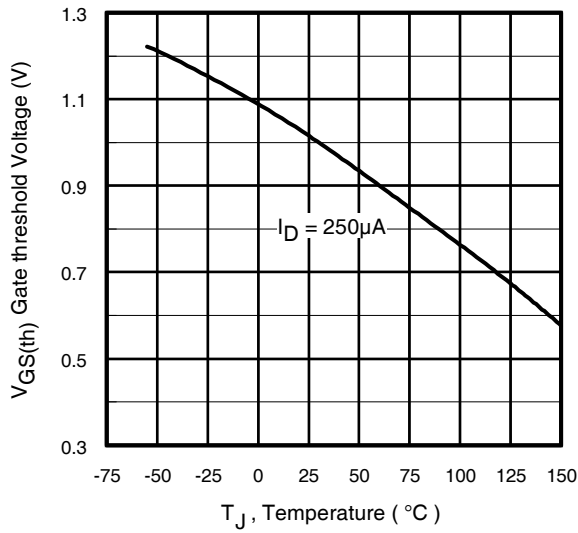


Fig 15. Typical Threshold Voltage Vs. Junction Temperature

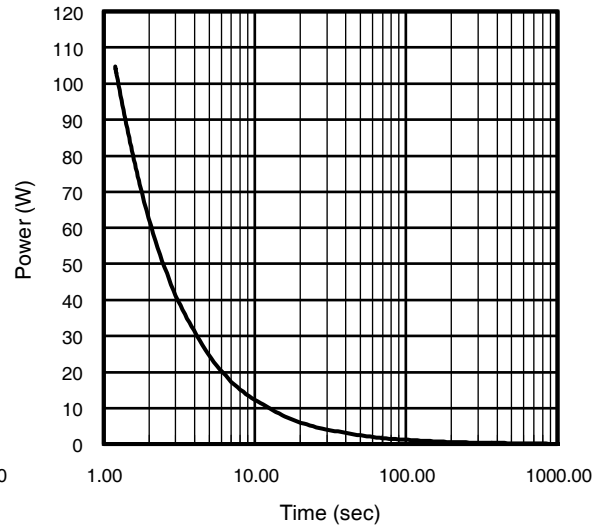


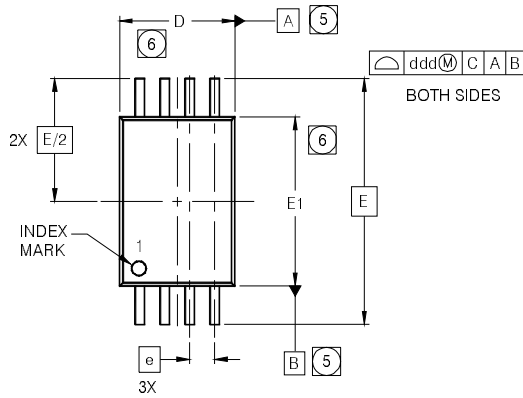
Fig 16. Typical Power Vs. Time

IRF7757GPbF

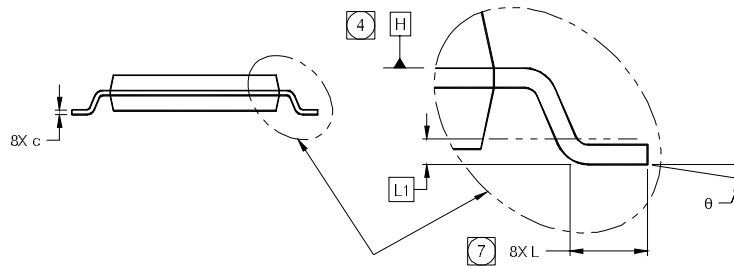
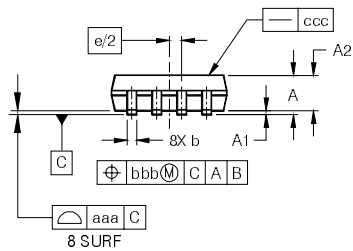
International
IR Rectifier

TSSOP8 Package Outline

Dimensions are shown in millimeters (inches)



| SYMBOL | MO-153AA DIMENSIONS | | | | | |
|--------|---------------------|------|------|----------|-------|-------|
| | MILLIMETERS | | | INCHES | | |
| | MIN | NOM | MAX | MIN | NOM | MAX |
| A | --- | --- | 1.20 | --- | --- | .0472 |
| A1 | 0.05 | --- | 0.15 | .0020 | --- | .0059 |
| A2 | 0.80 | 1.00 | 1.05 | .032 | .039 | .041 |
| b | 0.19 | --- | 0.30 | .0075 | --- | .0118 |
| c | 0.09 | --- | 0.20 | .0036 | --- | .0078 |
| D | 2.90 | 3.00 | 3.10 | .115 | .118 | .122 |
| E | 6.40 BSC | | | .251 BSC | | |
| E1 | 4.30 | 4.40 | 4.50 | .170 | .173 | .177 |
| e | 0.65 BSC | | | .0256 | | |
| L | 0.45 | 0.60 | 0.75 | .0178 | .0236 | .0290 |
| L1 | 0.25 BSC | | | .010 BSC | | |
| θ | 0° | --- | 8° | 0° | --- | 8° |
| aaa | 0.10 | | | .0039 | | |
| bbb | 0.10 | | | .0039 | | |
| ccc | 0.05 | | | .0019 | | |
| ddd | 0.20 | | | .0078 | | |



LEAD ASSIGNMENTS



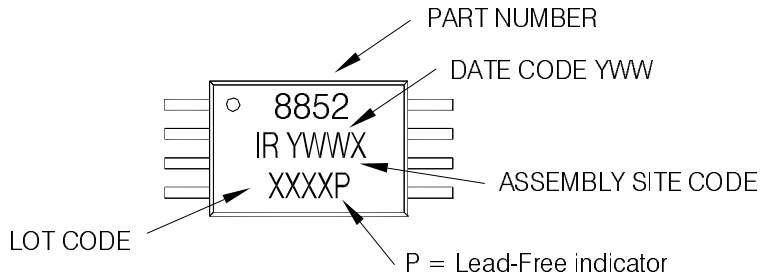
NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- DIMENSIONS ARE SHOWN IN MILLIMETERS AND INCHES.
- CONTROLLING DIMENSION: MILLIMETER.
- DATUM PLANE H IS LOCATED AS SHOWN.
- DATUM A AND B TO BE DETERMINED AT DATUM PLANE H.
- DIMENSIONS D AND E1 ARE MEASURED AT DATUM PLANE H.
- DIMENSION L IS THE LEAD LENGTH FOR SOLDERING TO A SUBSTRATE.
- OUTLINE CONFORMS TO JEDEC OUTLINE MO-153AA.

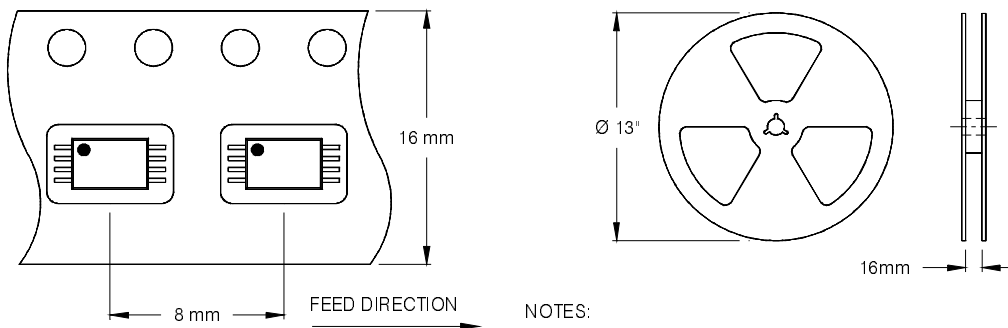
Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

TSSOP8 Part Marking Information

EXAMPLE: THIS IS AN IRF8852PBF



TSSOP-8 Tape and Reel Information



NOTES:

1. TAPE & REEL OUTLINE CONFORMS TO EIA-481 & EIA-541.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Data and specifications subject to change without notice.
 This product has been designed and qualified for the consumer market.
 Qualification Standards can be found on IR's Web site.

International
IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
 TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.05/2009